



Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Client **ATL (Auden)**

Certificate No: **D2450V2-712_Feb09**

CALIBRATION CERTIFICATE

Object **D2450V2 - SN: 712**

Calibration procedure(s) **QA CAL-05.v7**
Calibration procedure for dipole validation kits

Calibration date: **February 11, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: S5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name Mike Meili	Function Laboratory Technician	Signature
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Approved by:	Katja Pokovic	Technical Manager	
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Issued: February 11, 2009

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Certificate No: D2450V2-712_Feb09

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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.



Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz \pm 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 \pm 0.2) °C	38.0 \pm 6 %	1.82 mho/m \pm 6 %
Head TSL temperature during test	(22.0 \pm 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.1 mW / g
SAR normalized	normalized to 1W	52.4 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	51.8 mW /g \pm 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.13 mW / g
SAR normalized	normalized to 1W	24.5 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	24.3 mW /g \pm 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	53.9 ± 6 %	2.00 mho/m ± 6 %
Body TSL temperature during test	(21.1 ± 0.2) °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.2 mW / g
SAR normalized	normalized to 1W	52.8 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	52.3 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	6.18 mW / g
SAR normalized	normalized to 1W	24.7 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	24.7 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	55.7 Ω + 1.1 j Ω
Return Loss	- 25.2 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.5 Ω + 5.0 j Ω
Return Loss	- 26.0 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.158 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	July 5, 2002

DASY5 Validation Report for Head TSL

Date/Time: 04.02.2009 12:44:28

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN712

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB

Medium parameters used: $f = 2450$ MHz; $\sigma = 1.82$ mho/m; $\epsilon_r = 38$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.4, 4.4, 4.4); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

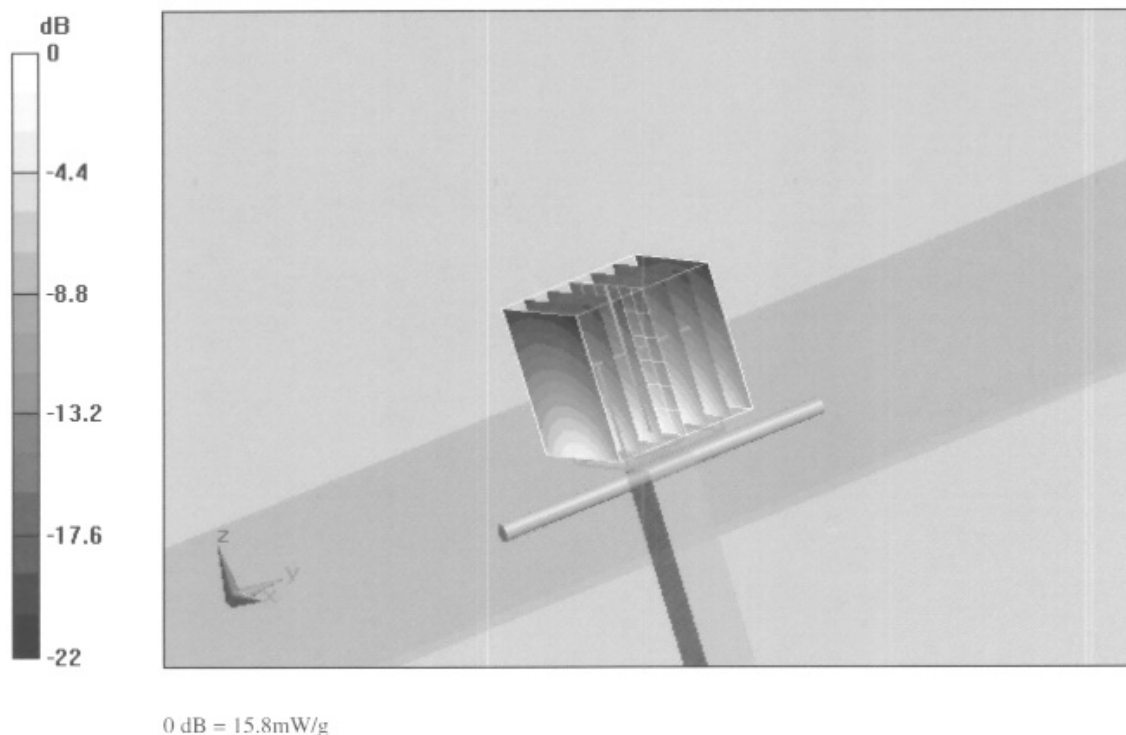
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.6 V/m; Power Drift = 0.00522 dB

Peak SAR (extrapolated) = 27.5 W/kg

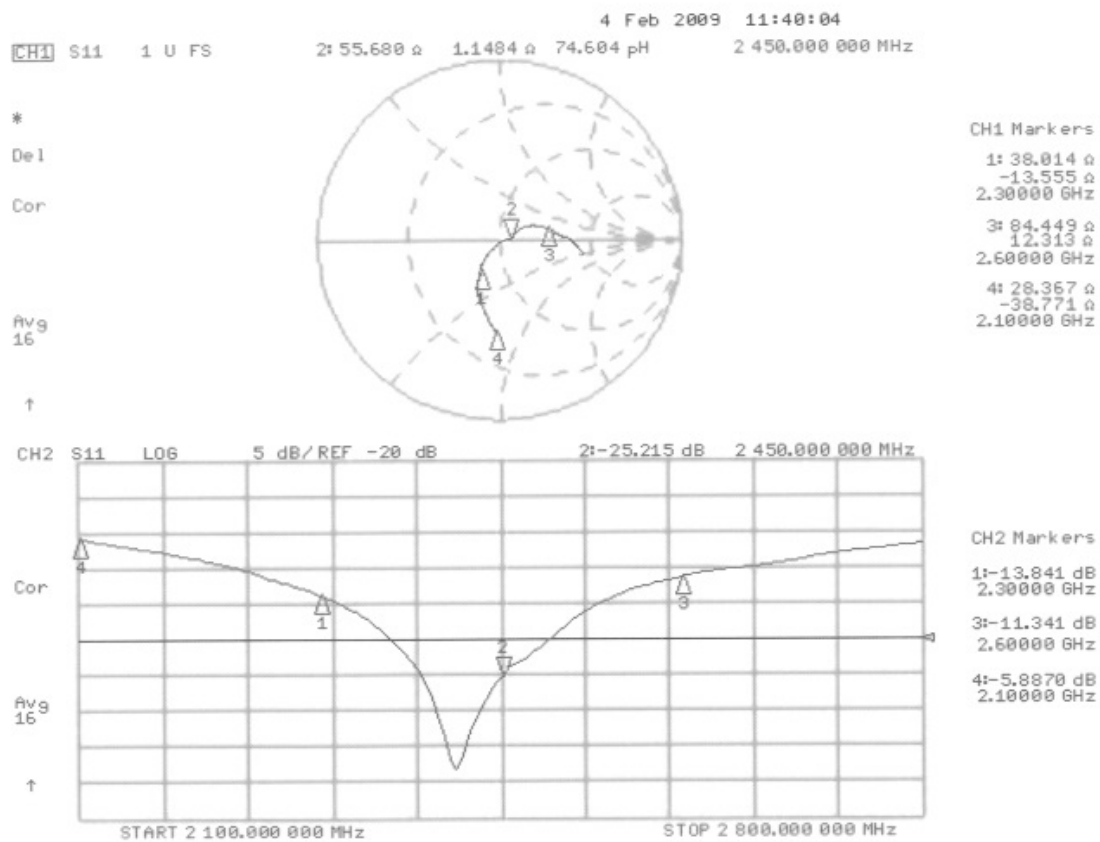
SAR(1 g) = 13.1 mW/g; SAR(10 g) = 6.13 mW/g

Maximum value of SAR (measured) = 15.8 mW/g





Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date/Time: 11.02.2009 11:51:07

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:712

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB

Medium parameters used: $f = 2450$ MHz; $\sigma = 2.01$ mho/m; $\epsilon_r = 54$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.07, 4.07, 4.07); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

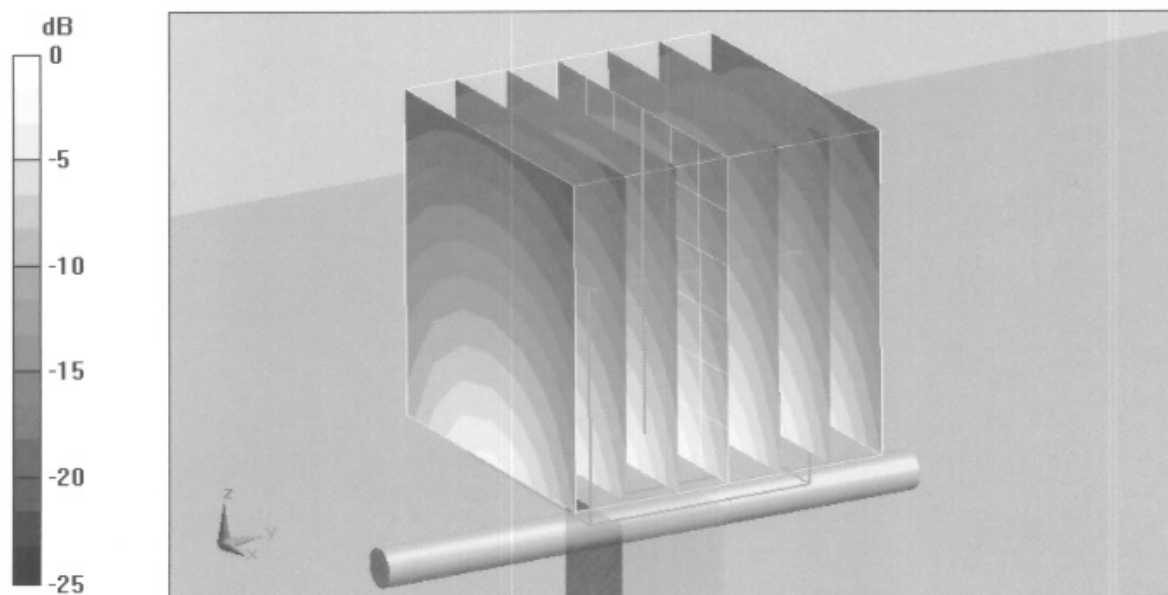
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 92.8 V/m; Power Drift = 0.00271 dB

Peak SAR (extrapolated) = 26.7 W/kg

SAR(1 g) = 13.2 mW/g; SAR(10 g) = 6.18 mW/g

Maximum value of SAR (measured) = 16.4 mW/g



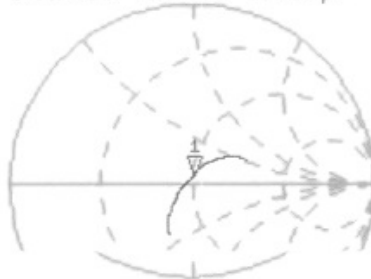
0 dB = 16.4mW/g



Impedance Measurement Plot for Body TSL

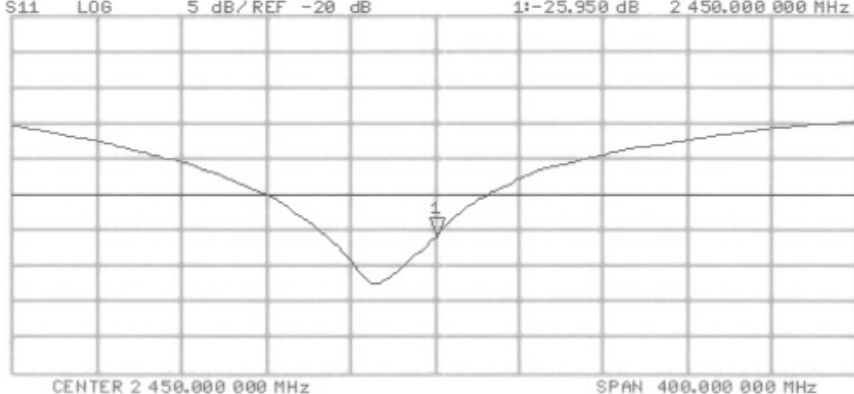
11 Feb 2009 11:01:58
[CH1] S11 1 U FS 1: 50.471 Ω 5.0469 Ω 327.85 μH 2 450.000 000 MHz

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De l
CA



CH2 S11 L06 5 dB/REF -20 dB 1:-25.950 dB 2 450.000 000 MHz

CA
Avg
16





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Accreditation No.: **SCS 108**

Client **ATL (Auden)**

Certificate No: **ES3-3150_Apr09**

CALIBRATION CERTIFICATE

Object **ES3DV3 - SN:3150**

Calibration procedure(s) **QA CAL-01.v6 and QA CAL-23.v3
Calibration procedure for dosimetric E-field probes**

Calibration date: **April 28, 2009 (Additional Conversion Factors)**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41498087	1-Apr-09 (No. 217-01030)	Apr-10
Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
Reference Probe ES3DV2	SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10
DAE4	SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: April 29, 2009

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Certificate No: ES3-3150_Apr09

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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization ϕ	ϕ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ES3DV3 SN:3150

April 28, 2009

Probe ES3DV3

SN:3150

Additional Conversion Factors

Manufactured:	June 12, 2007
Last calibrated:	January 20, 2009
Recalibrated:	April 28, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



ES3DV3 SN:3150

April 28, 2009

DASY - Parameters of Probe: ES3DV3 SN:3150

Sensitivity in Free Space^A

NormX	1.25 ± 10.1%	$\mu V/(V/m)^2$
NormY	1.26 ± 10.1%	$\mu V/(V/m)^2$
NormZ	1.25 ± 10.1%	$\mu V/(V/m)^2$

Diode Compression^B

DCP X	93 mV
DCP Y	95 mV
DCP Z	94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 5.

Sensor Center to Phantom Surface Distance	3.0 mm	4.0 mm
SAR _{be} [%] Without Correction Algorithm	11.0	6.8
SAR _{be} [%] With Correction Algorithm	0.8	0.5

TSL 1900 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance	3.0 mm	4.0 mm
SAR _{be} [%] Without Correction Algorithm	11.8	8.0
SAR _{be} [%] With Correction Algorithm	0.9	0.6

Sensor Offset

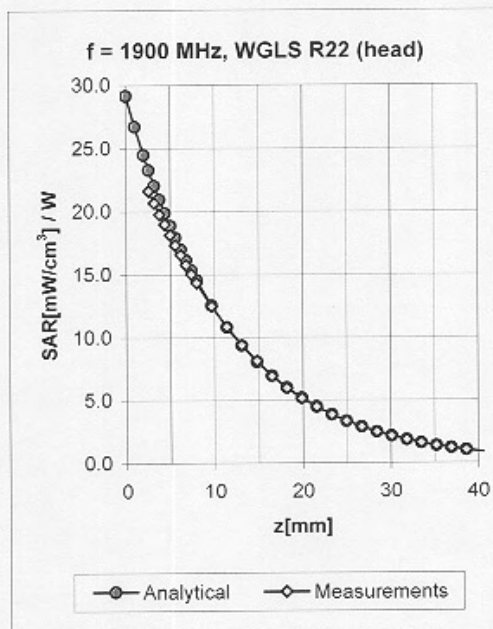
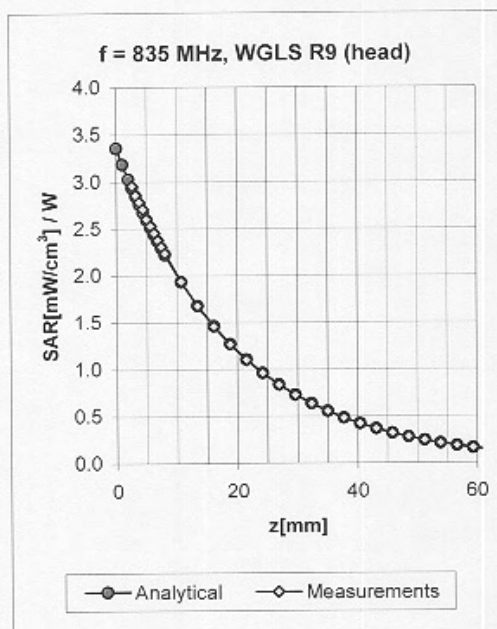
Probe Tip to Sensor Center	2.0 mm
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The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.59	1.41	6.05 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.38	2.11	5.12 ± 11.0% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.99	1.13	6.02 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.41	2.15	4.81 ± 11.0% (k=2)

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



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Accreditation No.: **SCS 108**

Client **ATL (Auden)**

Certificate No: **DAE3-393_Aug09**

CALIBRATION CERTIFICATE

Object **DAE3 - SD 000 D03 AA - SN: 393**

Calibration procedure(s) **QA CAL-06.v20**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **August 24, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	05-Jun-09 (in house check)	In house check: Jun-10

Calibrated by:	Name	Function	Signature
	Andrea Guntli	Technician	

Approved by:	Name	Function	Signature
	Fin Bornholt	R&D Director	

Issued: August 26, 2009

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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.



DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.906 \pm 0.1% (k=2)	404.156 \pm 0.1% (k=2)	404.066 \pm 0.1% (k=2)
Low Range	3.99061 \pm 0.7% (k=2)	3.96370 \pm 0.7% (k=2)	3.96389 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	303.5 $^{\circ}$ \pm 1 $^{\circ}$
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Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200006.9	-2.85	-0.00
Channel X + Input	20003.94	4.04	0.02
Channel X - Input	-19994.54	5.36	-0.03
Channel Y + Input	200007.3	-1.44	-0.00
Channel Y + Input	19999.38	-0.52	-0.00
Channel Y - Input	-19996.11	3.79	-0.02
Channel Z + Input	200005.3	-2.72	-0.00
Channel Z + Input	19995.60	-4.30	-0.02
Channel Z - Input	-20007.61	0.04	0.04

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	1999.8	-0.09	-0.00
Channel X + Input	199.02	-0.78	-0.39
Channel X - Input	-201.46	-1.36	0.68
Channel Y + Input	2000.1	-0.03	-0.00
Channel Y + Input	198.18	-1.72	-0.86
Channel Y - Input	-202.53	-2.43	1.21
Channel Z + Input	1999.9	-0.12	-0.01
Channel Z + Input	197.86	-2.14	-1.07
Channel Z - Input	-202.57	-2.37	1.18

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.46	11.20
	- 200	-9.35	-11.28
Channel Y	200	9.96	9.34
	- 200	-10.98	-11.10
Channel Z	200	4.16	3.81
	- 200	-5.83	-5.62

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.58	0.25
Channel Y	200	2.49	-	5.70
Channel Z	200	3.07	-0.41	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16158	17049
Channel Y	16025	16973
Channel Z	16453	17372

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.30	-1.39	0.81	0.27
Channel Y	-0.46	-1.50	0.96	0.31
Channel Z	-0.14	-1.43	1.13	0.33

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	200.6
Channel Y	0.2000	200.4
Channel Z	0.2001	200.2

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9